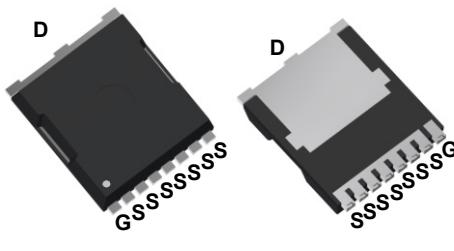
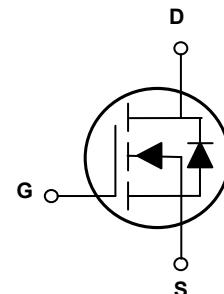


## Main Product Characteristics

$BV_{DSS}$	100V
$R_{DS(ON)}$	1.7mΩ (Max.)
$I_D$	300A



TOLL



Schematic Diagram

## Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



## Description

The GSGTL1R710 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

## Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous ( $T_C=25^\circ\text{C}$ )	$I_D$	300	A
Drain Current-Continuous ( $T_C=100^\circ\text{C}$ )		192	A
Drain Current-Pulsed <sup>1</sup>	$I_{DM}$	1200	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	2500	mJ
Single Pulse Avalanche Current <sup>2</sup>	$I_{AS}$	100	A
Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	480	W
Power Dissipation-Derate above 25°C		3.20	W/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62	°C/W
Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	0.31	°C/W
Operating Junction Temperature Range	$T_J$	-55 To +175	°C
Storage Temperature Range	$T_{STG}$	-55 To +175	°C

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	-	-	V
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	100	
Gate-Source Leakage Current	$I_{\text{GSS}}$	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=\pm 20\text{V}$	-	-	$\pm 100$	nA
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$I_{\text{D}}=30\text{A}, V_{\text{GS}}=10\text{V}$	-	1.3	1.7	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.1	-	3.9	V
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=15\text{A}$	-	36	-	S
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge <sup>3,4</sup>	$Q_g$	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=20\text{A}, V_{\text{GS}}=10\text{V}$	-	151	-	nC
Gate-Source Charge <sup>3,4</sup>	$Q_{\text{gs}}$		-	48	-	
Gate-Drain Charge <sup>3,4</sup>	$Q_{\text{gd}}$		-	30	-	
Turn-On Delay Time <sup>3,4</sup>	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=50\text{V}, R_{\text{G}}=6\Omega, V_{\text{GS}}=10\text{V}, I_{\text{D}}=20\text{A}$	-	36	-	nS
Rise Time <sup>3,4</sup>	$t_r$		-	26	-	
Turn-Off Delay Time <sup>3,4</sup>	$t_{\text{d}(\text{off})}$		-	90	-	
Fall Time <sup>3,4</sup>	$t_f$		-	40	-	
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	10600	-	pF
Output Capacitance	$C_{\text{oss}}$		-	3742	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	61	-	
Gate Resistance	$R_g$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, f=1\text{MHz}$	-	1.2	-	$\Omega$
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Continuous Source Current	$I_s$	$V_G=V_D=0\text{V}, \text{Force Current}$	-	-	300	A
Pulsed Source Current	$I_{\text{SM}}$		-	-	600	A
Diode Forward Voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_s=20\text{A}, T_J=25^\circ\text{C}$	-	-	1.2	V
Reverse Recovery Time	$t_{\text{rr}}$	$V_R=100\text{V}, I_s=20\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$	-	55	-	nS
Reverse Recovery Charge	$Q_{\text{rr}}$		-	333	-	nC

Notes:

1. Repetitive rating: Pulsed width limited by maximum junction temperature.
2.  $V_{\text{DD}}=50\text{V}, V_{\text{GS}}=10\text{V}, L=0.5\text{mH}, R_{\text{G}}=25\Omega$ , starting  $T_J=25^\circ\text{C}$ .
3. Pulsed test: Pulse width  $\leq 300\text{us}$ , duty cycle  $\leq 2\%$ .
4. Essentially independent of operation temperature.

## Typical Electrical and Thermal Characteristic Curves

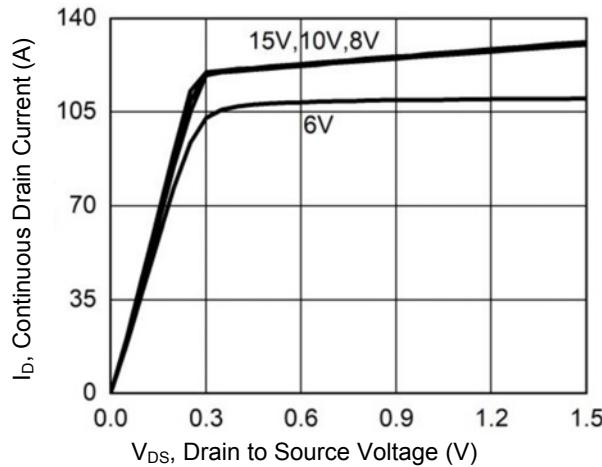


Figure 1. Typical Output Characteristics

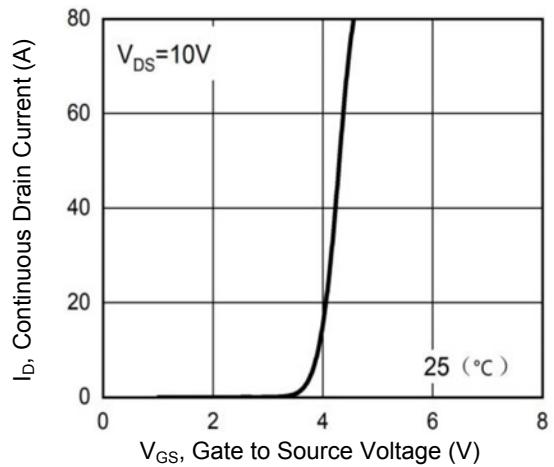


Figure 2. Typical Transfer Characteristics

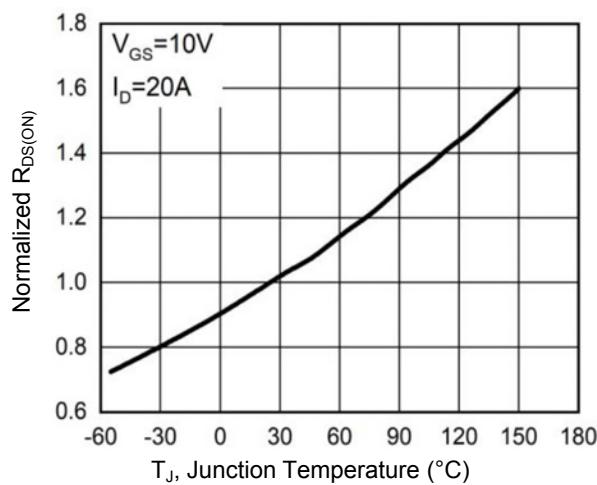


Figure 3. Normalized  $R_{DS(ON)}$  vs.  $T_J$

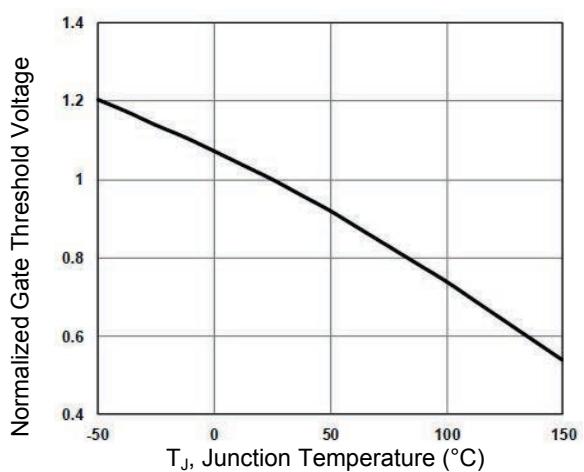


Figure 4. Normalized  $V_{th}$  vs.  $T_J$

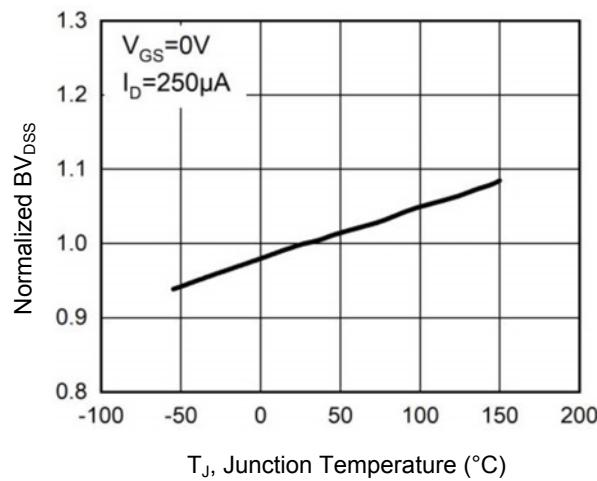


Figure 5. Normalized  $BV_{DSS}$  VS.  $T_J$

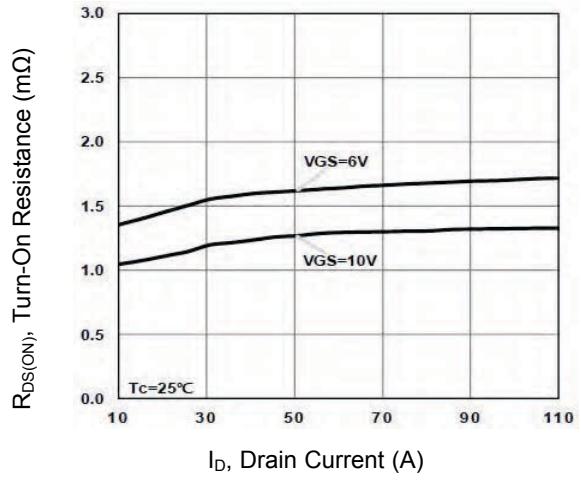


Figure 6. Turn-On Resistance vs.  $I_D$

### Typical Electrical and Thermal Characteristic Curves

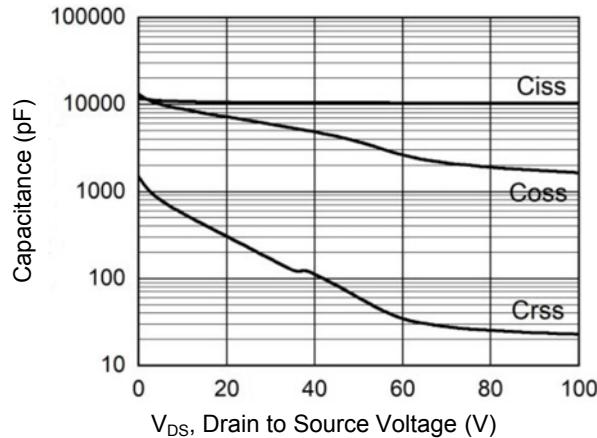


Figure 7. Capacitance Characteristics

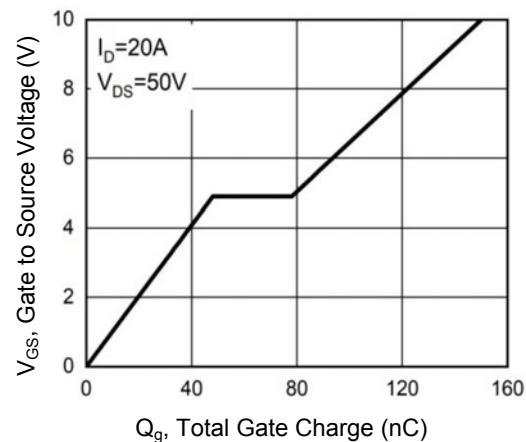


Figure 8. Gate Charge Characteristics

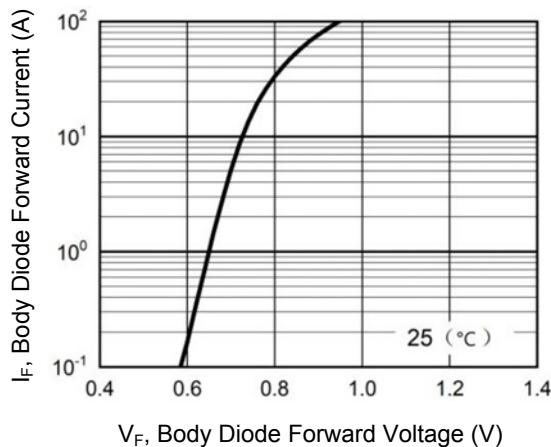


Figure 9. Body Diode Characteristics

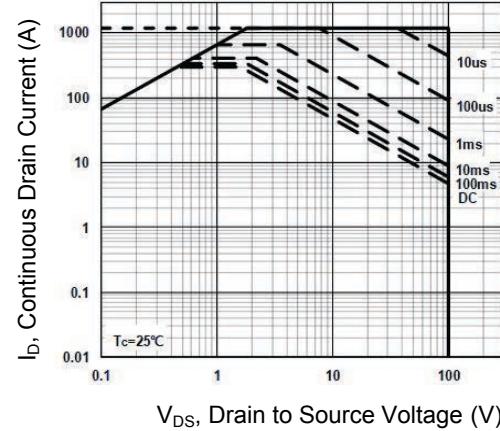
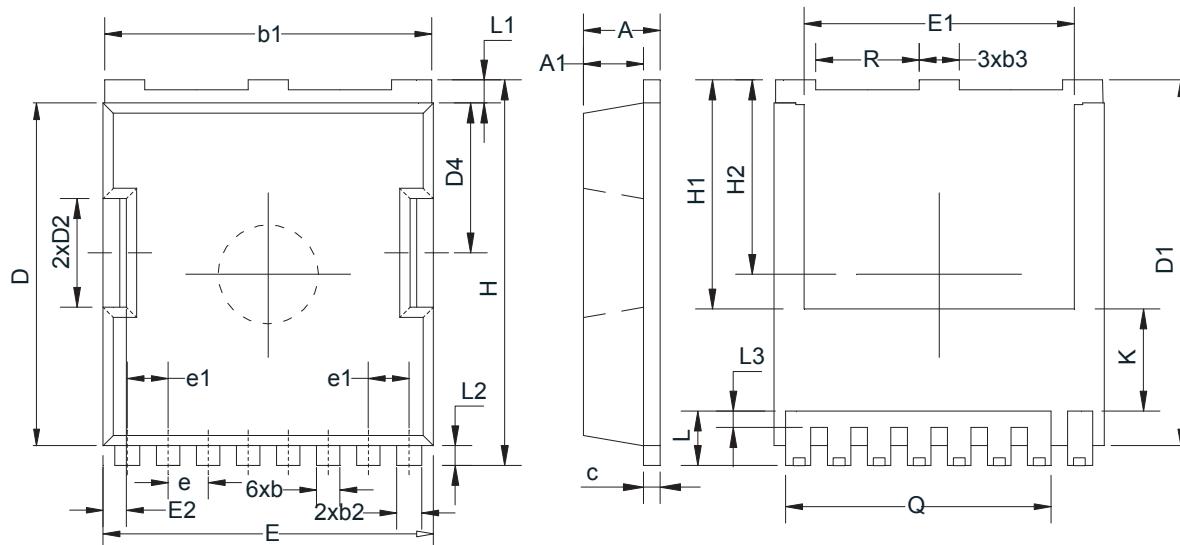


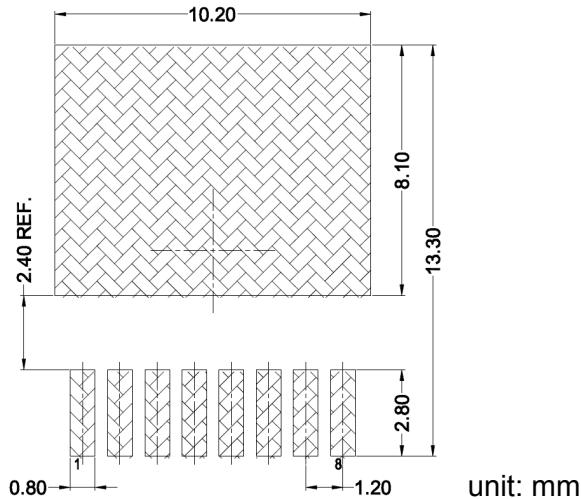
Figure 10. Maximum Safe Operation Area

### Package Outline Dimensions (TOLL)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.25	2.35	0.089	0.093
A1	1.75	1.85	0.069	0.073
b	0.65	0.75	0.026	0.030
b1	9.75	9.85	0.384	0.388
b2	0.70	0.80	0.028	0.031
b3	1.15	1.25	0.045	0.049
c	0.45	0.55	0.018	0.022
D	10.35	10.45	0.407	0.411
D1	11.00	11.20	0.433	0.441
D2	3.25	3.35	0.128	0.132
D4	4.50	4.60	0.177	0.181
e	1.200 BSC		0.047 BSC	
e1	1.225 BSC		0.048 BSC	
E	9.85	9.95	0.388	0.392
E1	8.00	8.20	0.315	0.323
E2	0.65	0.75	0.026	0.030
H	11.60	11.80	0.457	0.465
H1	6.95 BSC		0.274 BSC	
H2	5.90 BSC		0.232 BSC	
K	3.10 REF		0.122 REF	
L	1.55	1.75	0.061	0.069
L1	0.65	0.75	0.026	0.030
L2	0.50	0.70	0.020	0.028
L3	0.40	0.60	0.016	0.024
Q	7.95 REF		0.313 REF	
R	3.05	3.15	0.120	0.124

## Recommended Pad Layout



## Order Information

Device	Package	Marking	Carrier	Quantity
GSGTL1R710	TOLL	TL1R710	Tape & Reel	2,000 Pcs / Reel